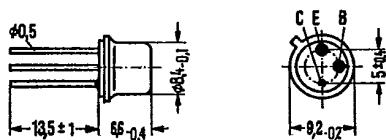


BSY 34 and BSY 58 are double diffused epitaxial NPN silicon planar transistors in TO 39 case (5 C 3 DIN 41873). The collectors are electrically connected to the cases.

The transistors are intended for use as high-speed switches and in particular for driving magnetic cores.

Type	Ordering code
BSY 34	Q60218-Y34
BSY 58	Q60218-Y58



Approx. weight 1.6 g

Dimensions in mm

Maximum ratings

	BSY 34	BSY 58	
Collector-emitter voltage	V_{CEO}	40	25
Collector-emitter voltage	V_{CES}	60	50
Collector-base voltage	V_{CBO}	60	50
Emitter-base voltage	V_{EBO}	5	5
Collector current	I_C	600	600
Base current	I_B	200	200
Junction temperature	T_j	200	200
Storage temperature range	T_{stg}	-65 to +200	-65 to +200
Total power dissipation ($T_{case} \leq 45^\circ\text{C}$) P_{tot}		2.6	2.6

Thermal resistance

Junction to ambient air	R_{thJA}	≤ 220	≤ 220	K/W
Junction to case	R_{thJC}	≤ 60	≤ 60	K/W

Static characteristics ($T_{amb} = 25^\circ\text{C}$; $V_{CE} = 1\text{ V}$)

Type	BSY 34			BSY 58			
	I_C mA	h_{FE} I_C/I_B	$V_{BEsat}^{(1)}$ V	$V_{CEsat}^{(1)}$ V	h_{FE} I_C/I_B	$V_{BEsat}^{(1)}$ V	$V_{CEsat}^{(1)}$ V
1	23	0.62	—	23	0.62	—	—
10	37	0.7	—	37	0.7	—	—
100	42 (> 25)*	0.85	0.17	42 (> 17)*	0.85	0.17	—
500	25 (> 10)	1.2 (< 1.5)*	0.6 (< 1)*	25	1.2 (< 1.5)*	0.6 (< 1.5)*	—

1) The transistor is saturated to such an extent that the DC current gain decreases to $h_{FE} = 10$.
* AQL = 0.66%

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Static characteristics	BSY 34		BSY 58		°C
	T_{amb}	150	25	25	
Collector cutoff current ($V_{CBO} = 50$ V)	I_{CBO}	$<7 \cdot 10^4$	$<70^\circ$	$<120^\circ$	nA
Collector-emitter breakdown voltage ($I_{CEO} = 10$ mA)	$V_{(BR)CEO}$		>40	>25	V
Collector-emitter breakdown voltage ($I_{CES} = 10$ μ A)	$V_{(BR)CES}$		>60	>50	V
Collector-base breakdown voltage ($I_{CBO} = 100$ μ A)	$V_{(BR)CBO}$		>60	>50	V
Emitter-base breakdown voltage ($I_{EBO} = 100$ μ A)	$V_{(BR)EBO}$		>5	>5	V

Dynamic characteristics ($T_{amb} = 25^\circ\text{C}$)

Transition frequency ($I_C = 30$ mA; $V_{CE} = 10$ V; $f = 100$ MHz)	f_T	400 (>250)	400 (>250)	MHz
Collector-base capacitance ($V_{CBO} = 10$ V)	C_{CBO}	4.5 (<6)	4.5 (<6)	pF
Emitter-base capacitance ($V_{EBO} = 1$ V)	C_{EBO}	22	22	pF

Switching times

Operating point:

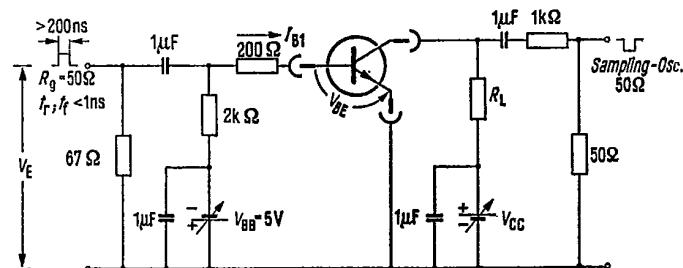
$I_C = 150$ mA; $I_{B1} = 15$ mA	t_{on}	30	35	ns
$-I_{B2} = 15$ mA; $R_L = 150$ Ω	t_{off}	50	60	ns

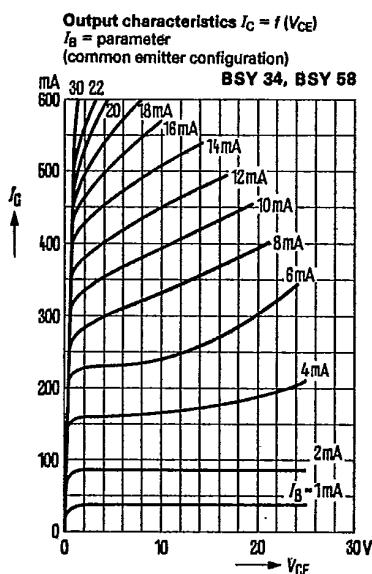
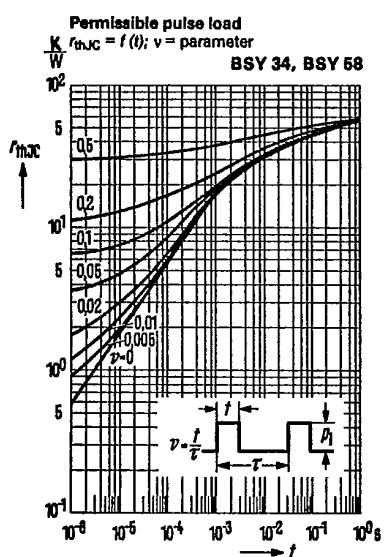
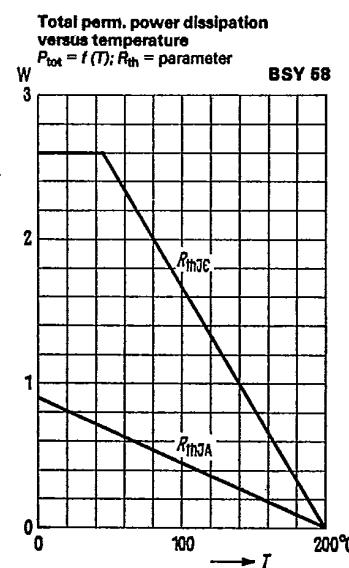
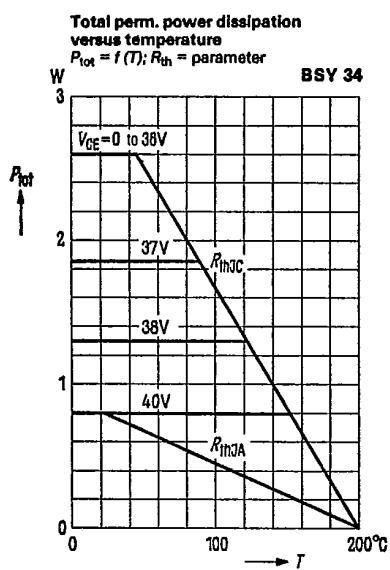
Operating point:

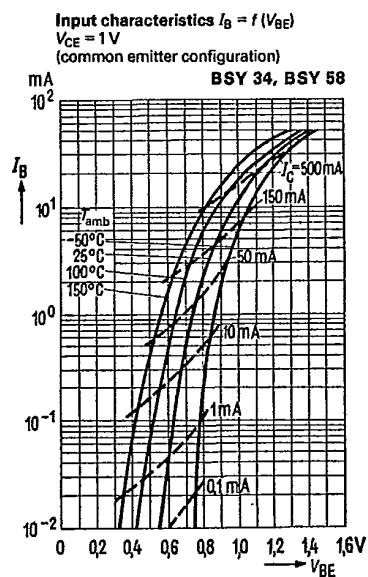
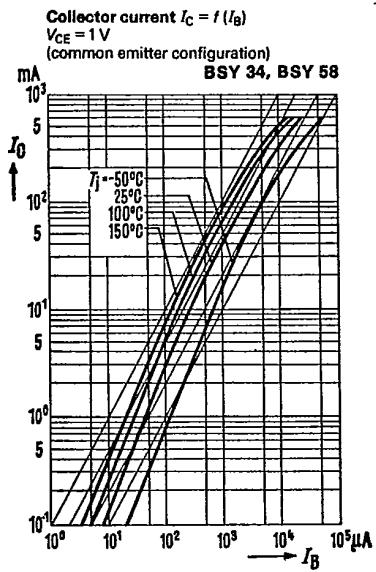
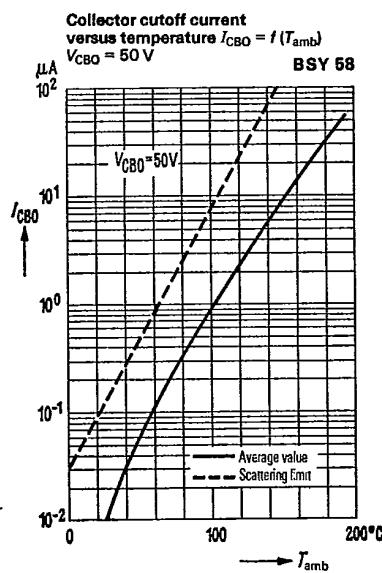
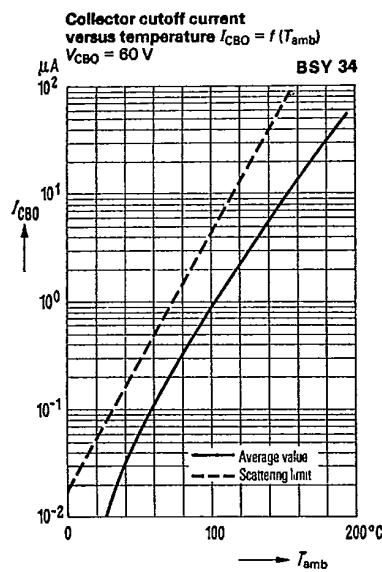
$I_C = 500$ mA; $I_{B1} = 50$ mA	t_{on}	30 (<50)	35 (<65)	ns
$-I_{B2} = 25$ mA; $V_E = 15$ V	t_{off}	65 (<95)	65 (<110)	ns

* AQL = 0.65%

Test circuit for switching times







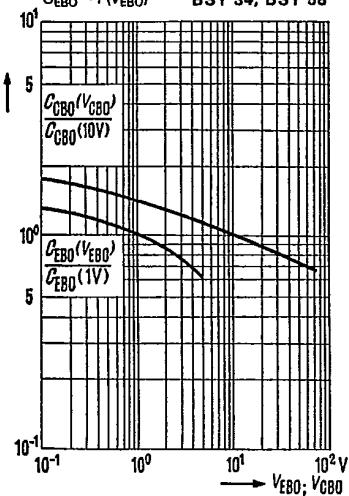
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Collector-base capacitance

$C_{CB0} = f(V_{CB0})$

Emitter-base capacitance

$C_{EB0} = f(V_{EB0}) \quad \text{BSY 34, BSY 58}$

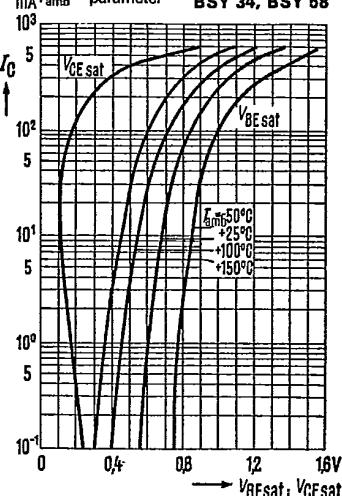
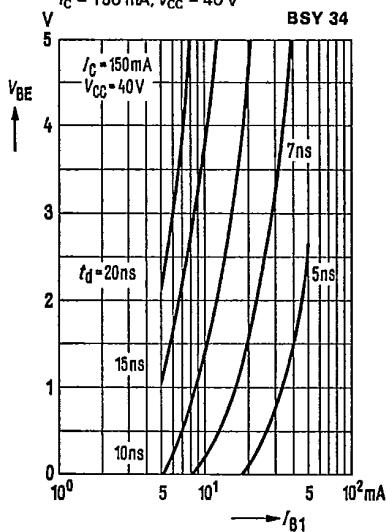


Saturation voltages

$V_{CEsat} = f(I_C); h_{FE} = 10$

$V_{BEsat} = f(I_C); h_{FE} = 10$

$\text{mA } T_{amb} = \text{parameter} \quad \text{BSY 34, BSY 58}$

Delay time t_d
 $I_C = 150 \text{ mA}; V_{CC} = 40 \text{ V}$ Rise time t_r
 $V_{CC} = 40 \text{ V}$ 